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| Notice of References Cited | Application/Control No. 10/804,040 | | Applicant(s)/Patent Under Reexamination SHIMAMURA ET AL. | |
| | Examiner Essama Omgba | | Art Unit 3726 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-2003/0208903 A1 | 11-2003 | Morbitzer et al. | 29/791 |
| * | B | US-2005/0198804 A1 | 09-2005 | Koren, Yoram | 029/430 |
| * | C | US-3,837,063 | 09-1974 | Wright, Robert Charles | 227/2 |
| * | D | US-3,840,962 | 10-1974 | Coller, James Ray | 29/56.6 |
| * | E | US-3,932,931 | 01-1976 | Wright, Robert Charles | 29/842 |
| * | F | US-4,099,324 | 07-1978 | Johnson et al. | 29/739 |
| * | G | US-4,476,627 | 10-1984 | Matsuura et al. | 29/791 |
| * | H | US-5,295,778 | 03-1994 | Hirai et al. | 29/739 |
| * | I | US-5,456,001 | 10-1995 | Mori et al. | 29/739 |
| * | J | US-5,509,191 | 04-1996 | Best, Norman D. | 29/722 |
| * | K | US-5,515,599 | 05-1996 | Best, Norman D. | 29/705 |
| * | L | US-5,768,768 | 06-1998 | Best, Norman D. | 29/792 |
| * | M | US-6,086,641 | 07-2000 | Shironouchi, Toshiaki | 29/25.01 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------------|----------------|
| | N | JP 2005064287 A | 03-2005 | Japan | SHIMAMURA et al. | H01L 21/50 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/804,040 | Applicant(s)/Patent Under Reexamination SHIMAMURA ET AL. | |
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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-6,409,642 B2 | 06-2002 | Tominaga et al. | 483/16 |
| * | B | US-6,691,405 B1 | 02-2004 | Kagei, Hiroshi | 29/832 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
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|---|---|---|
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| | V | |
| | W | |
| | X | |

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